

## Product Summary

$V_{(BR)DSS}$	$R_{DS(ON)}$ Max	$I_D$ Max @ $T_A = +25^\circ\text{C}$
-30V	$2.4\Omega$ @ $V_{GS} = -10\text{V}$	-400mA
	$4\Omega$ @ $V_{GS} = -4.5\text{V}$	-300mA

## Description

This MOSFET is designed to minimize the on-state resistance ( $R_{DS(ON)}$ ) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

## Applications

- Load Switch
- Portable Applications
- Power Management Functions

## Features

- Low On-Resistance
- Ultra-Small Surfaced Mount Package
- ESD Protected Gate
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**

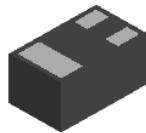
## Mechanical Data

- Case: X1-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound.  
UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – NiPdAu over Copper Leadframe.  
Solderable per MIL-STD-202, Method 208 <sup>(e4)</sup>
- Weight: 0.001 grams (Approximate)

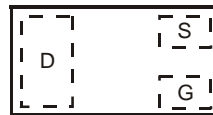


ESD PROTECTED

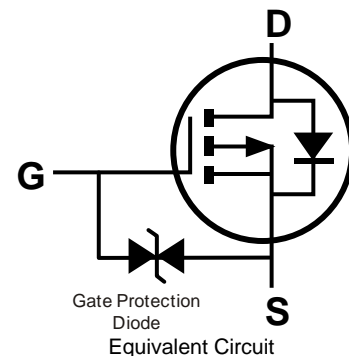
X1-DFN1006-3



Bottom View



Top View



## Ordering Information (Note 4)

Part Number	Reel Size (inches)	Quantity per Reel
DMP32D5SFB-7B	7	10,000

- Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
  2. See [http://www.diodes.com/quality/lead\\_free.html](http://www.diodes.com/quality/lead_free.html) for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  4. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

## Marking Information



Top View  
Bar Denotes Gate and Source Side

XH = Product Type Marking Code

**Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V <sub>DSS</sub>	-30	V
Gate-Source Voltage			V <sub>GSS</sub>	±25	V
Continuous Drain Current (Note 5)	V <sub>GS</sub> = -10V	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	I <sub>D</sub>	-400 -300	mA
Continuous Drain Current (Note 6)	V <sub>GS</sub> = -10V	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	I <sub>D</sub>	-500 -400	mA
Pulsed Drain Current (Note 5)			I <sub>DM</sub>	-1	A
Maximum Body Diode Continuous Current (Note 6)			I <sub>S</sub>	-800	mA

**Thermal Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation	(Note 5)	P <sub>D</sub>	0.5	W
	(Note 6)		1.2	
Thermal Resistance, Junction to Ambient	(Note 5)	R <sub>θJA</sub>	255	°C/W
	(Note 6)		108	
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

**Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition	
<b>OFF CHARACTERISTICS (Note 7)</b>							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	-	-	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -1mA	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	-	-	-1	µA	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	-	-	±10	µA	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	
<b>ON CHARACTERISTICS (Note 7)</b>							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-1.3	-	-2.3	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250µA	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	-	-	2.4	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -200mA	
				4		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -200mA	
Diode Forward Voltage	V <sub>SD</sub>	-	0.8	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = -300mA	
<b>DYNAMIC CHARACTERISTICS (Note 8)</b>							
Input Capacitance	C <sub>ISS</sub>	-	51	100	pF	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, f = 1.0MHz	
Output Capacitance	C <sub>OSS</sub>	-	11	20	pF		
Reverse Transfer Capacitance	C <sub>RSS</sub>	-	9	20	pF		
Total Gate Charge	Q <sub>g</sub>	-	0.62	2	nC	V <sub>GS</sub> = -4.5V	V <sub>DS</sub> = -10V, I <sub>D</sub> = -200mA
Total Gate Charge	Q <sub>g</sub>	-	1.25	4	nC	V <sub>GS</sub> = -10V	
Gate-Source Charge	Q <sub>gs</sub>	-	0.16	0.5	nC		
Gate-Drain Charge	Q <sub>gd</sub>	-	0.21	0.5	nC		
Turn-On Delay Time	t <sub>D(ON)</sub>	-	4.3	10	ns	V <sub>DS</sub> = -15V, I <sub>D</sub> = -500mA V <sub>GS</sub> = -10V, R <sub>G</sub> = 1Ω	
Turn-On Rise Time	t <sub>r</sub>	-	7.7	15	ns		
Turn-Off Delay Time	t <sub>D(OFF)</sub>	-	31.9	60	ns		
Turn-Off Fall Time	t <sub>f</sub>	-	17.8	40	ns		

- Notes:
- Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
  - Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout.
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to production testing.

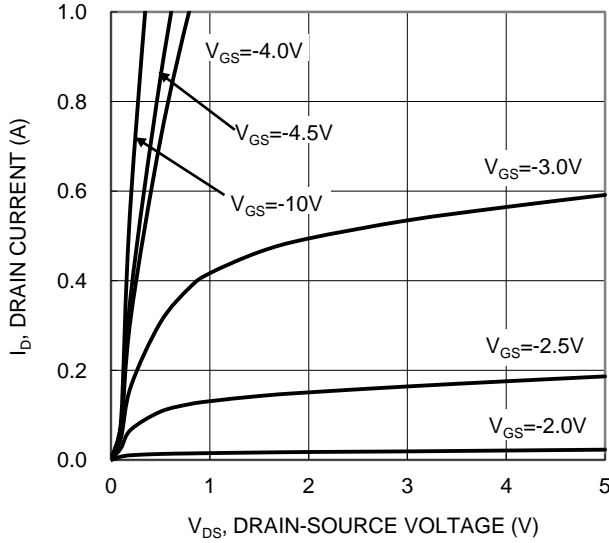


Figure 1. Typical Output Characteristic

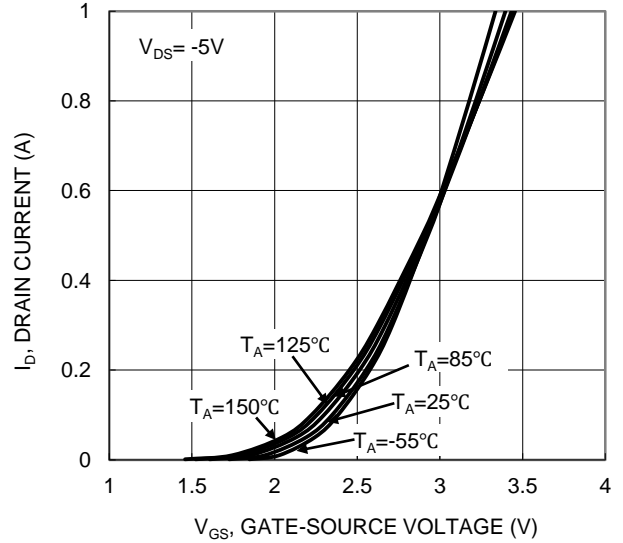


Figure 2. Typical Transfer Characteristic

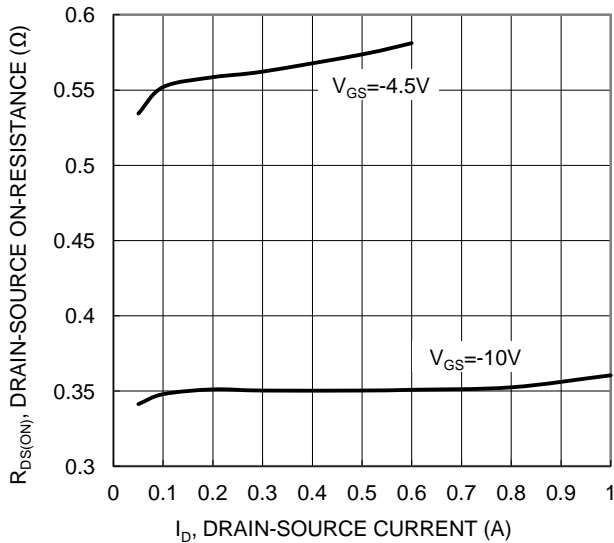


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

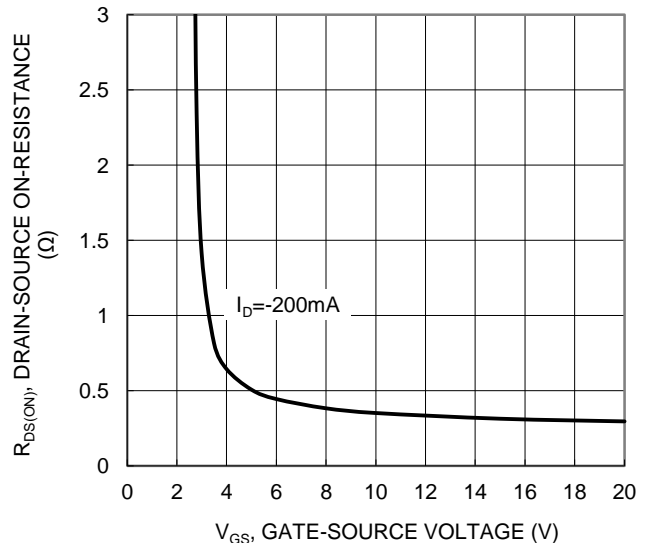


Figure 4. Typical Transfer Characteristic

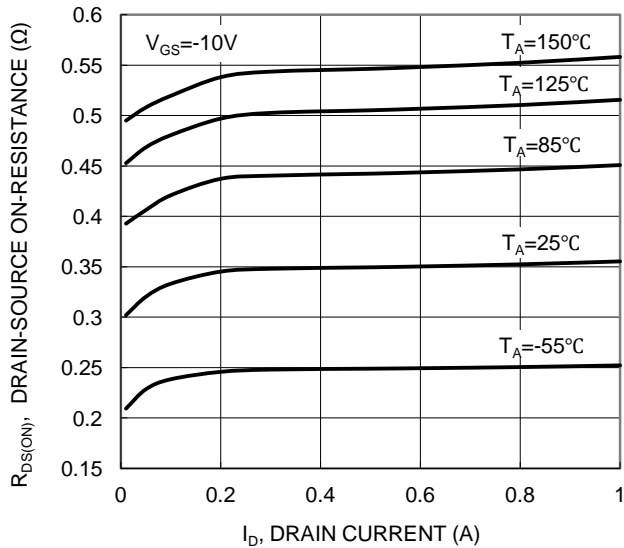


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

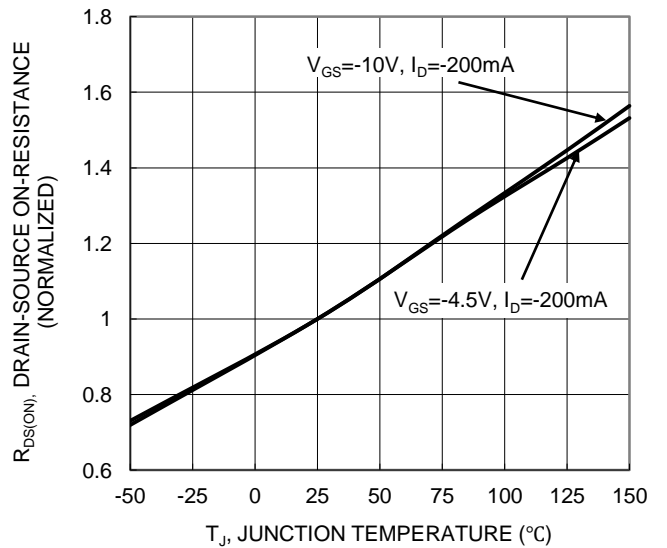
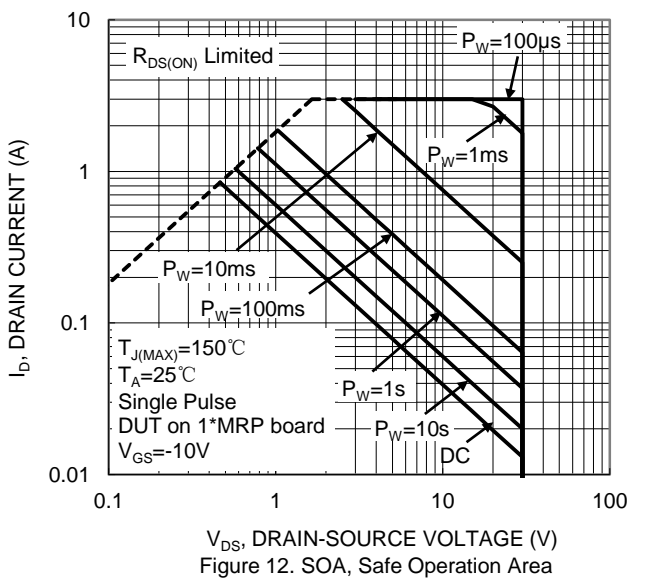
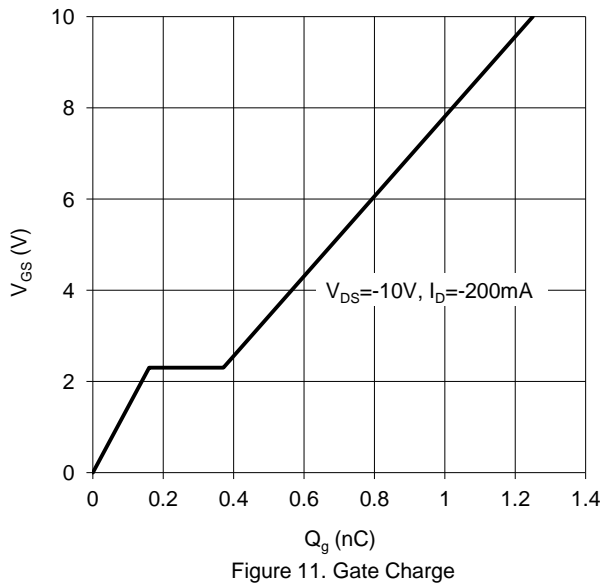
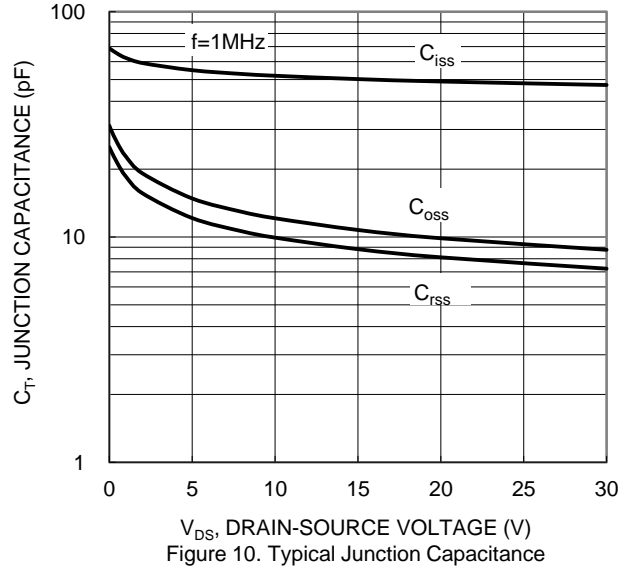
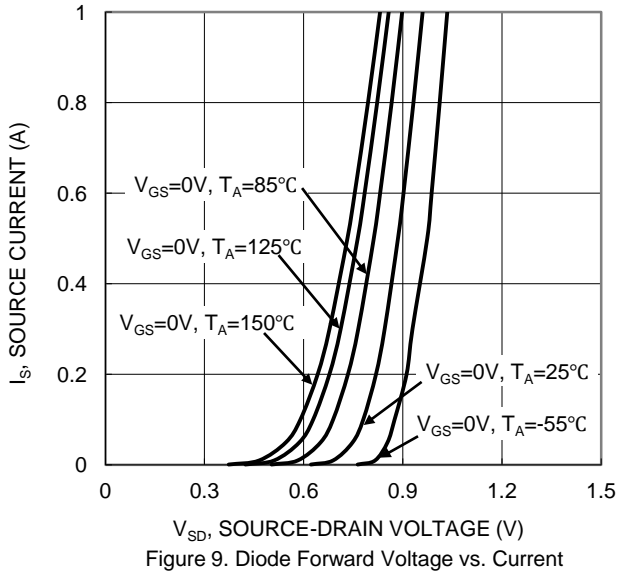
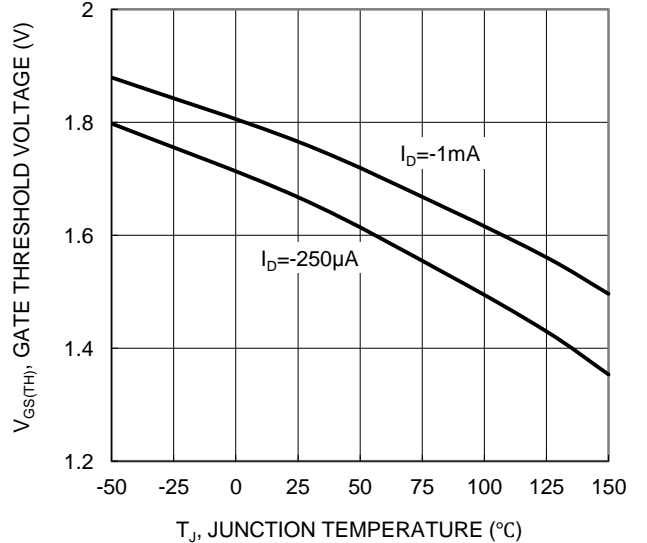
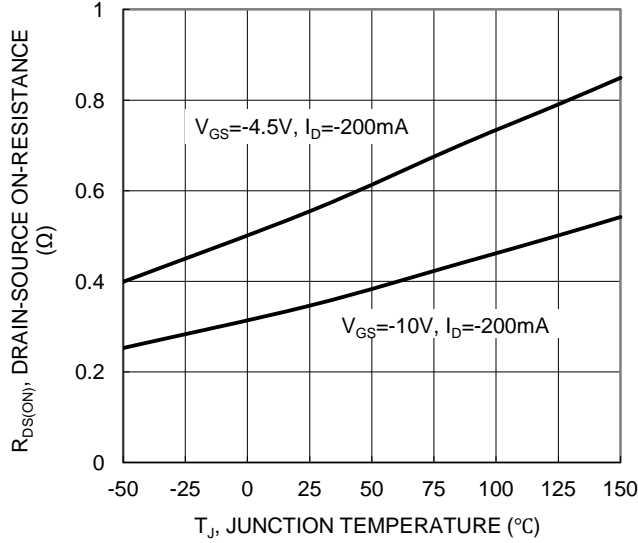


Figure 6. On-Resistance Variation with Temperature



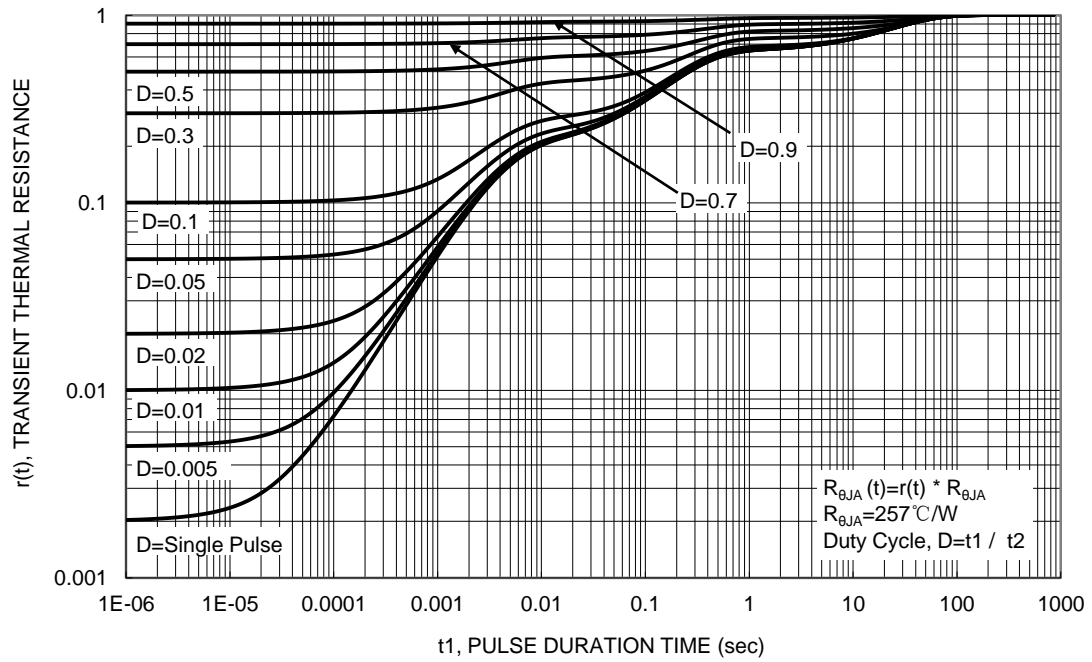
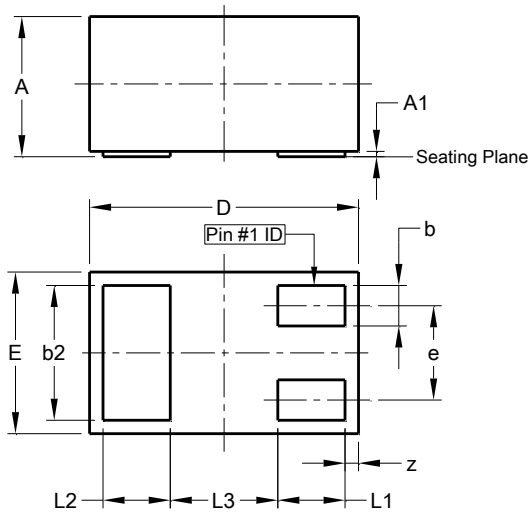


Figure 13. Transient Thermal Resistance

**Package Outline Dimensions**

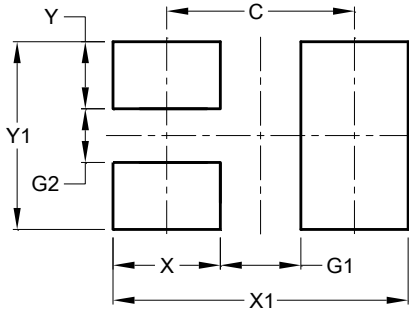
Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for the latest version.



X1-DFN1006-3			
Dim	Min	Max	Typ
A	0.47	0.53	0.50
A1	0.00	0.05	0.03
b	0.10	0.20	0.15
b2	0.45	0.55	0.50
D	0.95	1.075	1.00
E	0.55	0.675	0.60
e	-	-	0.35
L1	0.20	0.30	0.25
L2	0.20	0.30	0.25
L3	-	-	0.40
z	0.02	0.08	0.05
All Dimensions in mm			

**Suggested Pad Layout**

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for the latest version.



Dimensions	Value (in mm)
C	0.70
G1	0.30
G2	0.20
X	0.40
X1	1.10
Y	0.25
Y1	0.70

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